

L Number	Hits	Search Text	DB	Time stamp
2	610	(385/49).CCLS.	USPAT	2003/08/29 12:32
3	4	("4210923"   "4926545"   "4974041"   "5900763").PN.	USPAT	2003/08/29 12:29
4	23	385/\$3.ccls. and (testing near3 circuit)	USPAT	2003/08/29 12:34
5	2092	polish\$3 near3 fiber	USPAT	2003/08/29 12:35
6	58	((385/49).CCLS.) and (polish\$3 near3 fiber)	USPAT	2003/08/29 13:15
7	6	("5446815"   "5481632"   "5513290"   "5793914"   "6017681"   "6215946").PN.	USPAT	2003/08/29 12:36
8	9	5481632.URPN.	USPAT	2003/08/29 12:40
9	7	("4750799"   "4904036"   "4969712"   "5696862"   "5787215"   "5854867"   "6027255").PN.	USPAT	2003/08/29 12:45
10	16	5231683.URPN.	USPAT	2003/08/29 12:50
11	14	5712937.URPN.	USPAT	2003/08/29 12:51
12	16	5175781.URPN.	USPAT	2003/08/29 12:54
13	16	4871226.URPN.	USPAT	2003/08/29 12:55
14	3	5223911.URPN.	USPAT	2003/08/29 12:57
15	7	("4070094"   "4196964"   "4468085"   "4695121"   "4707059"   "4848910"   "4871226").PN.	USPAT	2003/08/29 12:58
16	1	("5712937").PN.	USPAT	2003/08/29 13:15
17	0	((("5712937").PN.) and matching	USPAT	2003/08/29 13:16
18	1	((("5712937").PN.) and match\$3	USPAT	2003/08/29 13:18
19	0	5109447.bn. and match\$3	USPAT	2003/08/29 13:19
20	0	5109447.bn. and index	USPAT	2003/08/29 13:21
21	75	385/49.ccls. and (index near3 match\$4)	USPAT	2003/08/29 13:21
22	2045	wafer near3 dicing	USPAT	2003/08/29 13:28
23	45	22.ti.	USPAT	2003/08/29 13:31
24	13712	testing near3 (wafer or circuit)	USPAT	2003/08/29 13:48
25	2045	wafer near3 dicing	USPAT	2003/08/29 13:31
26	284	(testing near3 (wafer or circuit)) and (wafer near3 dicing)	USPAT	2003/08/29 13:32
27	983	(index near3 match\$3) with fiber	USPAT	2003/08/29 13:32
28	0	((testing near3 (wafer or circuit)) and (wafer near3 dicing)) and ((index near3 match\$3) with fiber)	USPAT	2003/08/29 13:32
29	2697	testing with fiber	USPAT	2003/08/29 13:32
30	64	((index near3 match\$3) with fiber) and (testing with fiber)	USPAT	2003/08/29 13:32
31	38	((((index near3 match\$3) with fiber) and (testing with fiber)) and detector	USPAT	2003/08/29 13:46
32	0	(((((index near3 match\$3) with fiber) and (testing with fiber)) and detector) and ((testing near3 (wafer or circuit)) and (wafer near3 dicing))	USPAT	2003/08/29 13:47
33	1	((testing near3 (wafer or circuit)) and (wafer near3 dicing)) and (testing with fiber)	USPAT	2003/08/29 13:47
34	27	((testing near3 (wafer or circuit)) and (wafer near3 dicing)) and detector	USPAT	2003/08/29 13:53
35	131	(probe near2 test\$3) with wafer with dic\$3	USPAT	2003/08/29 14:16
36	206	probe near3 polish\$3	USPAT	2003/08/29 13:54
37	0	((probe near2 test\$3) with wafer with dic\$3) and (probe near3 polish\$3)	USPAT	2003/08/29 13:54
38	2092	fiber near3 polish\$3	USPAT	2003/08/29 13:54
39	0	((probe near2 test\$3) with wafer with dic\$3) and (fiber near3 polish\$3)	USPAT	2003/08/29 13:54
40	377	(probe near2 test\$3).ti.	USPAT	2003/08/29 13:55
41	10	((probe near2 test\$3) with wafer with dic\$3) and ((probe near2 test\$3).ti.)	USPAT	2003/08/29 13:55
42	0	((probe near2 test\$3) with wafer with dic\$3) and fiber	USPAT	2003/08/29 14:00
43	24	(probe near2 test\$3) with circuit with dic\$3	USPAT	2003/08/29 14:01
44	1	((probe near2 test\$3) with circuit with dic\$3) and fiber	USPAT	2003/08/29 14:01
45	0	fiber with (test\$3) with wafer with dic\$3	USPAT	2003/08/29 14:07
46	11	optic\$3 with (test\$3) with wafer with dic\$3	USPAT	2003/08/29 14:08
47	924	test\$3 with wafer with dic\$3	USPAT	2003/08/29 14:21

48	3562	fiber with coupl\$5 with (waveguide or wafer or circuit)	USPAT	2003/08/29 14:17
49	2	( test\$3 with wafer with dic\$3) and (fiber with coupl\$5 with (waveguide or wafer or circuit))	USPAT	2003/08/29 14:17
50	24	( test\$3 with wafer with dic\$3) and (optic\$3 near3 fiber)	USPAT	2003/08/29 14:24
51	74	(test\$3 near3 wafer with method).ti.	USPAT	2003/08/29 14:27
53	0	((test\$3 near3 wafer with method).ti.) and (test\$3 near3 wafer with (optic\$3 near3 fiber))	USPAT	2003/08/29 14:28
52	13	test\$3 near3 wafer with (optic\$3 near3 fiber)	USPAT	2003/08/29 14:40
54	42	test\$3 near3 circuit with (optic\$3 near3 fiber)	USPAT	2003/08/29 14:40
55	41	(test\$3 near3 circuit with (optic\$3 near3 fiber)) not (test\$3 near3 wafer with (optic\$3 near3 fiber))	USPAT	2003/08/29 14:45
56	1	("5631571").PN.	USPAT	2003/08/29 14:45
57	7	5631571.URPN.	USPAT	2003/08/29 14:45
58	11	("3832019"   "4563642"   "4627151"   "4685998"   "4722060"   "4755746"   "4845425"   "5157327"   "5170127"   "5381103"   "5412330").PN.	USPAT	2003/08/29 14:48